

POWER MOSFETs versus BIPOLAR TRANSISTORS

What is better, if anything, with the power FETs if we can get a bipolar transistor with an equal power rating for less than half the price?

Several manufacturers have recently introduced power FETs for RF amplifier applications. Devices with 100 W output capabilities are available for VHF frequencies and smaller units are made for UHF operation. All are enhancement mode devices, which means that the gate must be biased with positive voltage (N channel) in respect to the source to "turn it on." Early

designs were so called V-MOS FETs, where the channel is in a V-groove. The V-groove must be etched with a special process, and the silicon material must have a different crystal orientation from the material normally used for bipolar transistors. The difficulty of the etching process in production has led to the development of other types of channel structures such as HEX and T, which are still vertical channel structures, but V-groove is eliminated, and the gate is on a straight surface. Thus, for an equal gate periphery, more room

TABLE A

	Bipolar	TMOS FET
$Z_{in} RS/ XS(30 \text{ MHz})$:	0.65 - J0.35 Ohms	2.20 - J2.80 Ohms
$Z_{in} RS/ XS(150 \text{ MHz})$:	0.40 + J1.50 Ohms	0.65 - J0.35 Ohms
Z_{OL} (Load Impedance):	Almost equal in each case, depending on power level and supply voltage.	
Biasing:	Not required, except for linear operation, high current voltage source necessary.	Some gate bias always required. Low current source, such as resistor divider sufficient.
Ruggedness:	Fails usually under current conditions. Thermal runaway and secondary breakdown possible.	Failure modes: Gate punch through, exceeding of breakdown voltages, over dissipation.
Linearity:	Low order distortion depends on die size and geometry. High order IMD is a function of type and value of ballast resistors.	Low order distortion worse than bipolar for a given die size and geometry. High order IMD better due to lack of ballast resistors.
Advantages:	Wafer processing easier. Low collector-emitter saturation voltage, which makes devices for low voltage operation possible.	Input impedance more constant under varying drive level. Lower high order IMD. Easier to broadband. Devices or die can be paralleled. High voltage devices easy to implement.
Disadvantages:	Low input impedance with high reactive component. Internal matching required to lower Q. Input impedance varies with drive level. Devices or die can not easily be paralleled.	Larger die required for comparable power level. Nonrecoverable gate breakdown. High drain - source saturation voltage, which makes low voltage, high power devices less feasible.

on the surface is required. Japanese manufacturers seem to favor geometries with horizontal channels. They are similar to small signal MOSFETs with a number of them paralleled on one chip. This technique represents even more wasteful use of the die surface than HEX or TMOS. Typically a power FET requires 50 to 100 percent more die area than a bipolar transistor for equal power output performance. For TMOS the number is about 50 percent. This is mainly due to the higher saturation voltage, but the geometry also gives some 30 percent less gate periphery than available base area in bipolar. Since the price of a solid state device is a function of a die size, we get fewer watts per dollar. This is completely opposite from what the industry has been trying to do in the past years with bipolar transistors. So, one may ask: What is better, if anything, with the power FETs if we can get a bipolar transistor with an equal power rating for less than half the price? This is where we come to the purpose of this article, which is to discuss the characteristics of the FET and bipolar device. Both have the same basic geometry, but with some mask changes, one was processed as a MOSFET and the other as a bipolar.

CIRCUIT CONFIGURATIONS

Since the gate of a MOSFET device is essentially a capacitor, which consists of MOS capacitance distributed between the channel and the surface metalization, the input Q is normally extremely high. For this reason, the gate must be de-Q'ed with a shunt resistance or applying negative feedback or a combination of the two. Unless this is done properly, the affect of feedback capacitance (C_{RSS}) will result in conditions, where stable operation is impossible to achieve.

Figure 1 shows a Smith Chart plot of a 150 W MOS FET and a bipolar device using the same basic geometry for comparison purposes. The gate of the FET has been shunted by a resistance of 20 ohms. Without the shunt resistance the input impedance would be a pure capacitive reactance, if package inductances are disregarded.

The input Q is an inverse function of the broadband-ability of a device. With the techniques mentioned above, the Q can be controlled to a large degree, but some power gain will be sacrificed, unless only some type of selective negative feedback is employed for that purpose. Amplifiers in the 100 W power level, covering five octaves can be designed, and the limiting factor only seems to be the proper design of the broadband matching transformers.

Due to the lack of base diode junctions inherent to bipolar devices, where the diode forward conductance depends on the drive level, the MOSFET gate impedance varies only slightly with the input voltage amplitude. The gate MOS capacitance should be more or less independent of voltage, depending on the die processing. This is considered one of the advantages with FETs, especially regarding amplitude modulated applications, where a constant load for the driver stage is important. Negative feedback should be limited, since it tends to deteriorate this characteristic. Another advantage is the AGC capability by varying the gate voltage. In common source configuration, depending on the initial power gain, etc., an AGC range of 20 dB is achievable.

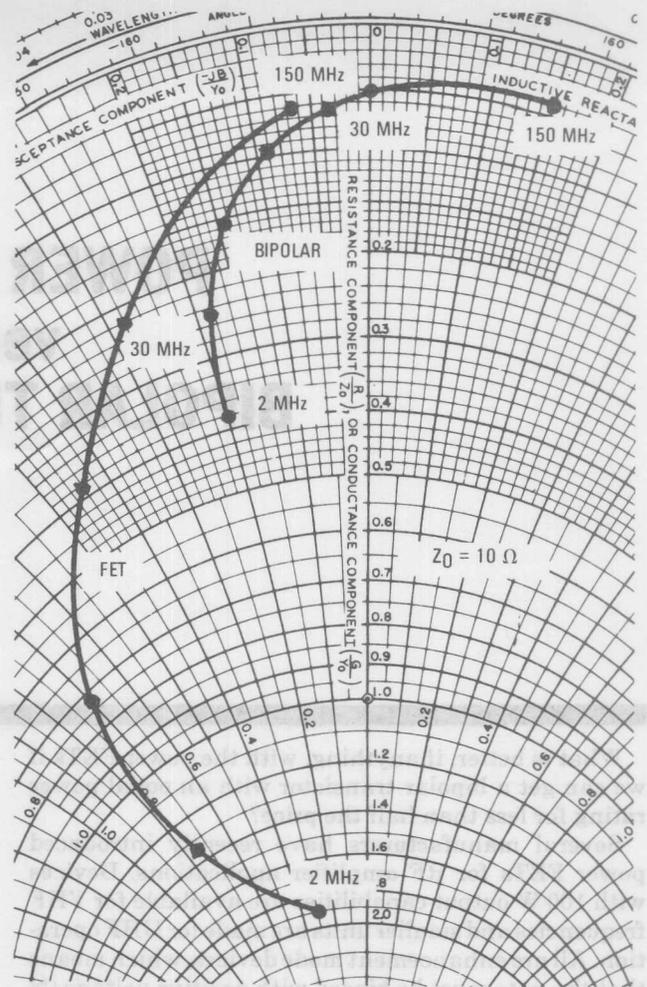


FIGURE 1 — 150 Watt MOSFET and Bipolar Comparison

Common gate configuration has some advantages, although it is not useful in applications requiring linearity. The load impedance is reflected back to the gate and in effect is in parallel with the source to ground impedance. The total input impedance is more constant with frequency than in common source mode, but varies greatly with output power level and supply voltage. As in a comparable configuration with bipolar transistors, the overall power gain is low, but the unity gain frequency (f_{α}) extends higher, which makes the common gate circuit attractive at UHF designs. It also

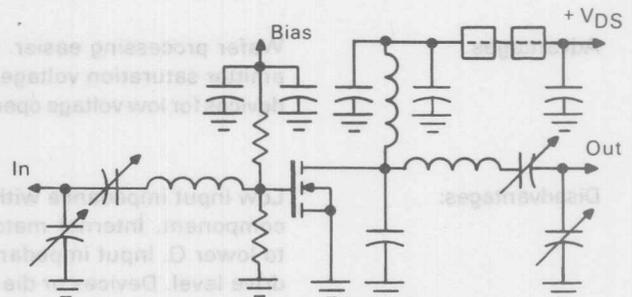


FIGURE 2 — A Typical Common Source MOSFET Power Amplifier Circuit

has more tendency for parasitic oscillations, since the input and output are in the same phase. The de-Q'ing of the input can be done in the same manner as in a common source circuit, but negative feedback is not as easy to implement. This circuit also exhibits greater power gain versus bias voltage variation characteristics. In applications, where 40 dB to 50 dB AGC range is required, the common gate configuration should be considered.

A common drain configuration represents the emitter follower in bipolar circuits. In both cases the input impedance is high and the load impedance is effectively in series with the input. The input capacitance, (drain-to-gate, or collector-to-base) is lower than in common source or common gate circuits, and several times lower for the FET than bipolar for equal die size. This is due to lack of the diode junction. A MOSFET source follower can not be regarded as having current gain as the emitter follower. The amplification rather takes place through impedance transformation. Due to the fair amount of input de-Q'ing required, the available power gain is lower than in common source circuit for example. Having less than unity voltage gain, the circuit exhibits exceptional stability, and negative feedback is not necessary, nor can it be easily implemented. Push pull broadband circuits for a frequency range of 2 to 50 MHz have been designed for 200-300 watt power levels. Their inherent characteristics are good linearity and gain flatness without any leveling networks. High power SSB amplifiers are probably the most suitable application for common drain operation. The AGC range is comparable to that in common source, but higher voltage swing is required. It must be noted that the MOS devices used must have high gate rupture voltage, since during the negative half cycle of the input signal, the gate voltage approaches the level of V_{DS} .

LINEARITY ASPECTS

Some literature claims that MOS power FETs are inherently more linear than the bipolar transistors. This is only true up to the point where envelope distortion, caused by saturation, instabilities or other reasons, is not present. It is also a function of the bias current (I_{DQ}). The FETs usually require higher idling currents than the bipolars to get full advantage of their linearity. Bipolars are usually biased only to get the base-emitter diode into forward conduction, whereafter increasing the bias helps little. Class A is an exception, but the device must then be operated at 20-25 percent of the rated Class AB level.

Probably the main advantage with the MOS power FETs is their greatly superior high order IMD distortion performance. This is mainly due to the fact that ballasting resistors are not required with FETs. In bipolar RF power transistors, nonlinear feedback is distributed to each emitter site through the MOS capacitance from the collector. In devices using diffused silicon resistors, this effect is even worse, and caused by additional nonlinear diode capacitance between the collector and the emitters. The high order IMD (9th and up) is actually in

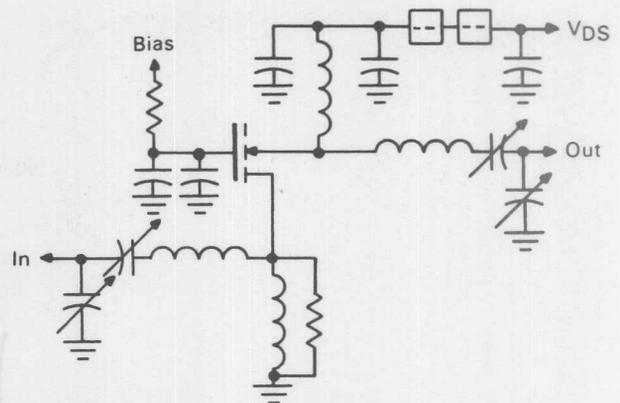


FIGURE 3 — A Typical Common Gate MOSFET Power Amplifier Circuit

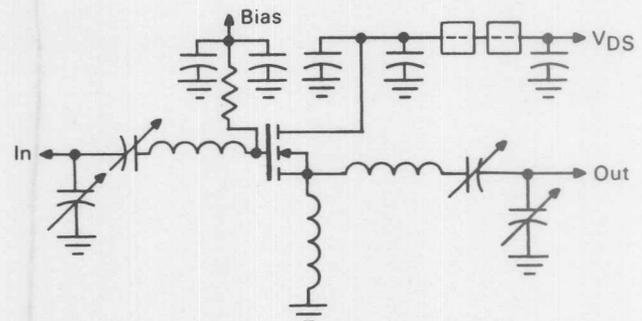


FIGURE 4 — A Typical Common Drain, Narrow Band MOSFET Power Amplifier Circuit

direct relation to the ballasting resistor values, which must be optimized for an even power distribution along the die. Too low values would result in a fragile device, and the opposite would, in addition to the IMD problem, result in high collector-emitter saturation voltage and low power gain.

The feedback capacitance, drain-to-gate or collector-to-base for example, also has a secondary effect in IMD. In both cases it is a function of the die geometry, and is usually lower with devices with higher figure of merit, such as the ones made for UHF and microwave applications. A MOS power FET exhibits some five times lower feedback capacitance than a bipolar transistor with a similar geometry. In a bipolar transistor this capacitance partly consists of the collector-base junction, which is highly nonlinear with voltage. This, together with the varying input impedance, generates internal feedback, which is nonlinear and produce high order IMD to some degree. A more noticeable effect is that the low order IMD goes up with reduced drive levels as shown in Figure 6.

This can be related to different turn on characteristics between the two device types. When a bipolar device is biased to Class AB, the bias does not usually, completely overcome the V_{BE} knee. Thus, at lower signal levels, the remaining nonlinear portion covers a larger area of the total voltage swing. Increasing the bias from the normally recommended Class AB values will help and full Class A should eliminate the problem completely.

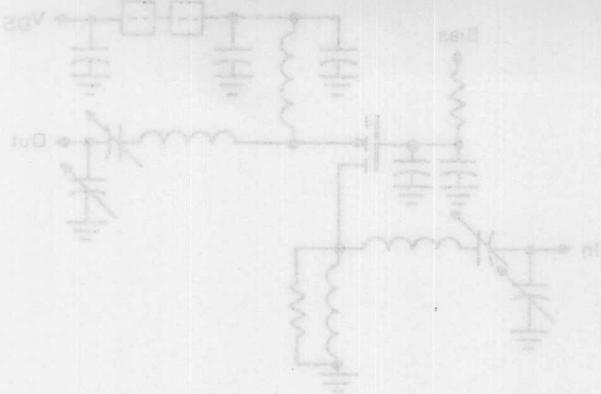


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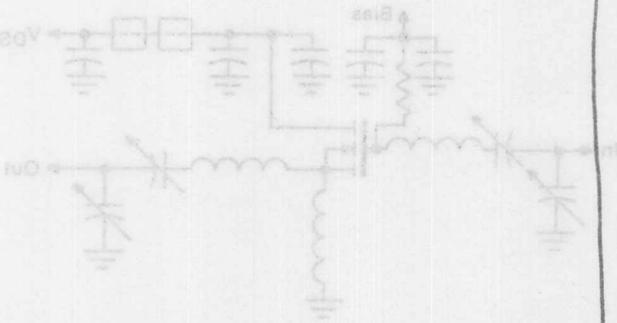


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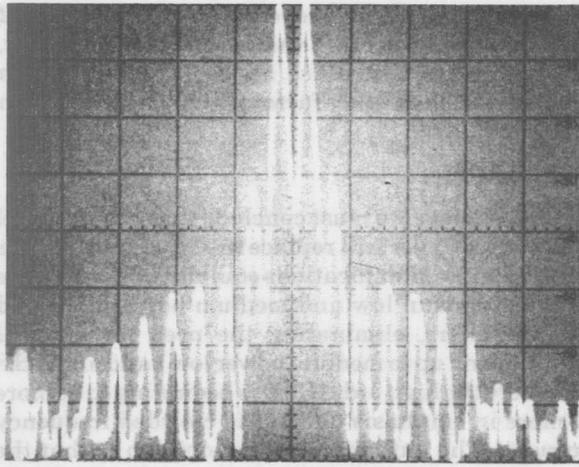
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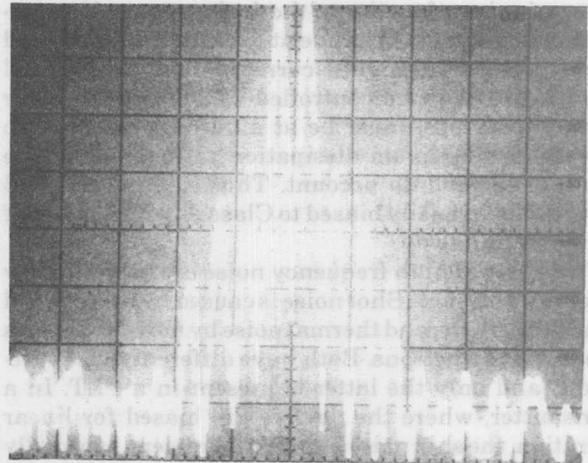
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a.



b.

FIGURE 5 — Two Tone Spectrographs of 300 W PEP, 50 V Amplifier Outputs

a. using bipolar transistors and b. with TMOS power FETs. 500 mA of bias current per device was used in each case. Doubling the bias current has a minimal effect in a. but b. the 7th order products would be lowered by 10-12 dB.

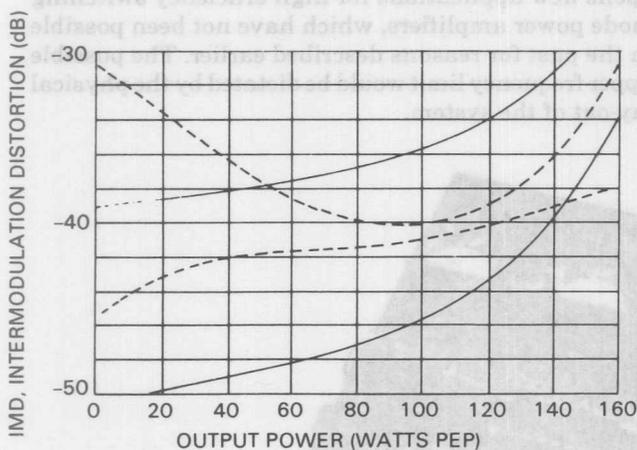


FIGURE 6 — IM Distortion as a Function of Power Output. Solid Curves MOSFET, Dashed Curves Bipolar Transistor

CLASS D/E APPLICATIONS

Switching mode RF power amplifiers have only become feasible since the introduction of the power FET. Being a majority carrier device, the FET does not exhibit the storage time phenomena, that limits the switching speed of a bipolar. For a given device, the switching speed is mainly determined by the speed the gate capacitance can be charged and discharged. If the capacitance is in the order of several hundred pF, a smaller FET is required to provide the fast charge-discharge switch. For low power stages, bipolars can be used, since the storage time is mainly an inverse function of the f_T and device size. The advantages of a Class D amplifier are high efficiency, linearity and ruggedness, since power is ideally dissipated only during the switching transitions.

These amplifiers are readily applicable for FM modulation, after harmonic filtering. The analog gain is obtained by pulse-width modulation of the input

switching signal, and demodulation of the output with suitable filters. Linearity is required only from the modulator, which is easy to achieve at small signal levels. The high speed voltage controlled one shot MC10198 should be ideal for a linear pulse-width modulator. By properly adjusting its operating point, low level AM or suppressed carrier double sideband signals can be generated.

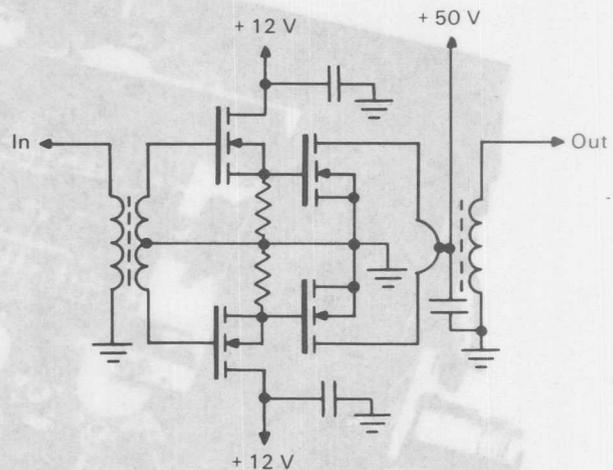


FIGURE 7 — A Typical Power MOSFET Class D RF Amplifier, Arranged in Push-Pull Configuration

GENERAL

All MOSFETs can in theory have a positive temperature coefficient on the gate threshold voltage. This means that the gate threshold voltage increases with temperature, trying to "turn the device off." In addition the g_m will decrease, which also helps in preventing the thermal runaway, which is commonly a problem with bipolars. The coefficient of the gate threshold

voltage is also a function of the drain current. Normally the coefficient is negative at low current levels, and turns positive at higher currents. The turnaround point, which can be controlled by doping the other fabrication steps, must be at a current level not to exceed the maximum dissipation rating, taking the derating factor into account. Thus, the power MOS devices can be easily biased to Class A, without fear of a thermal runaway.

Two types of high frequency noise are generated by bipolar transistors. Shot noise is caused by the forward biased junctions, and thermal noise by moving carriers upon flow of electrons. Both have different noise spectrums, and only the latter is present in a FET. In a transmitter, where the devices are biased for linear operation, the shot noise becomes a problem, especially if a receiver is in close proximity, as in transceiver designs. Also, if several stations are operated near each other, the noise can be transmitted through the antenna, disturbing the reception at nearby stations. In most instances, the bias of the power devices must be switched on and off during the transmit and receive functions, which will prevent a full break-in operation. Measurements of 150 W devices, intended for SSB applications, were performed at 30 MHz, at the proper idling current levels. The difference in the total noise figure between a bipolar and a FET is about three to

one, or 7 dB and 2.2 dB respectively. The amount of noise that can be tolerated varies with each situation, and whether the difference above is significant in practice depends on other factors involving the design of the equipment.

CONCLUSION

From the above we must conclude that it is doubtful the power FET ever will replace the bipolar transistor in all areas of communications equipment. It will have its applications in low and medium power VHF and UHF amplifiers, eliminating the need for internal matching, and up to medium power low band and VHF SSB, where the high order IMD is beginning to be more and more in emphasis due to the crowded frequency spectrums. The author's personal opinion is that the power FET is the most feasible device for the amplitude companded sideband (ACSB) applications, proposed for future use in land mobile communications. The system principle requires extreme linearity in the amplifying stages, which in the past has only been achieved with Class A operation. The power FET also opens new applications for high efficiency switching mode power amplifiers, which have not been possible in the past for reasons described earlier. The possible upper frequency limit would be dictated by the physical lay-out of the system.

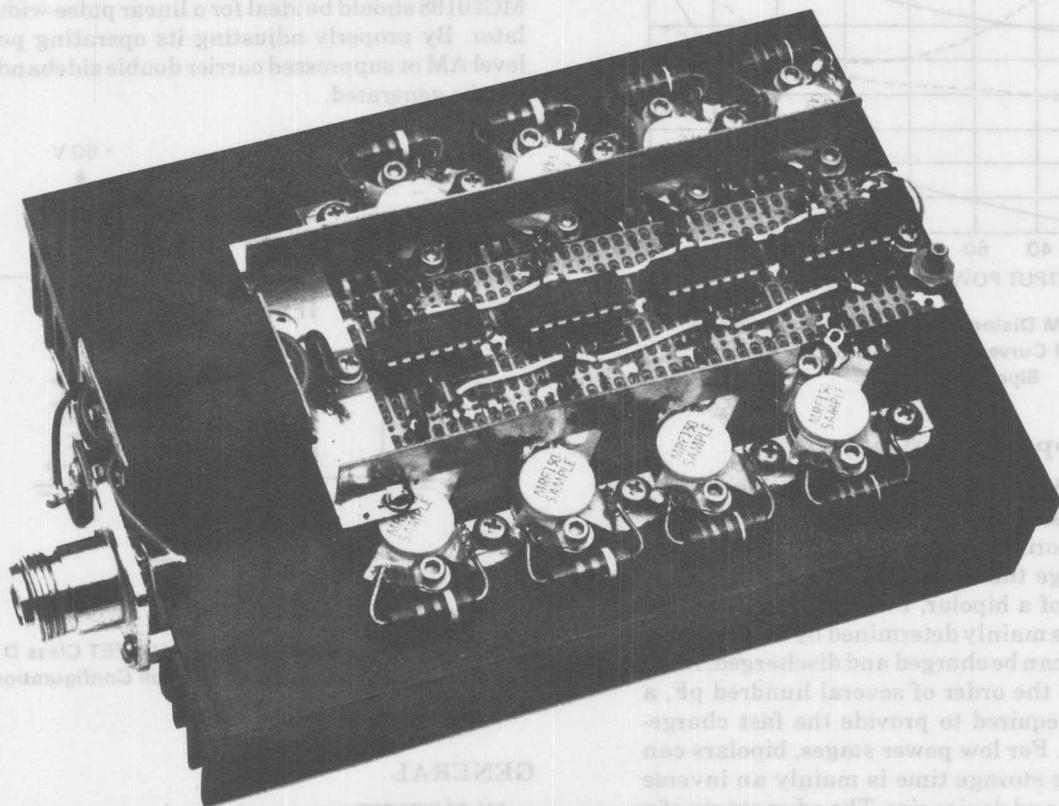


FIGURE 8 — An Experimental Three Stage, One Kilowatt Class D Amplifier.

The unit operates up to 10 MHz yielding an efficiency of 85 percent. The power gain is 30 dB.